

APPROVAL SHEET

MULTI LAYER CERAMIC INDUCTOR

High Frequency Application Purpose

Size 0402 (1005)

WL1005 Pb-Free Series

*Contents in this sheet are subject to change without prior notice.

REVISION HISTORY

Rev	P/N	Description	Date
V01	WL1005 Green Material series	First Version	2004-10-07
V02	WL1005 Green Material series	The "Tolerance" Of Ordering Information increased " $\pm 0.1nH$ " on Page-3	2005-06-09
V03	WL1005 Green Material series	Modify the specification of packing dimension on Page 9 : Chip cavity "A" dimension from 0.65 ± 0.1 mm to 0.685 ± 0.015 mm Chip cavity "B" dimension from 1.15 ± 0.1 mm to 1.215 ± 0.015 mm	2005-11-25

FEATURES

1. Ceramic structure provides high reliability · high productivity
2. Product Design via 3D EM Simulation Skill makes excellent Q and SRF characteristics
3. Miniaturized size 1.0 x 0.5 x 0.5 mm³
4. Pb Free products

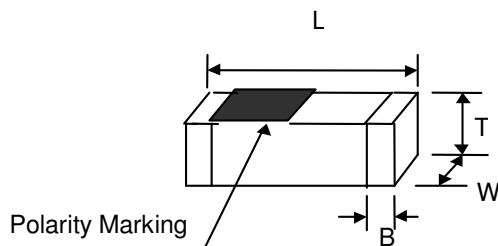
APPLICATIONS

Portable electronics and wireless segment includes mobile phones, Wireless LAN, HomeRF, Bluetooth application, telecommunication and EMI countermeasure in high frequency circuits.

DESCRIPTION

Walsin Technology Corporation develops a tiny size of 1.0 x 0.5 x 0.5 mm³ Multi Layer Ceramic Inductor (MLCI) consist of a rectangular block of ceramic foils on which low resistive silver metal electrodes are contained and connected via through hole. The inner electrodes are then connected to the two terminations. Adopt 3D EM simulation skill for product design makes Walsin Technology Corporation MLCIs provide excellent Q_Value and Self Resonant Frequency (SRF) characteristics to address application on high frequency band as well as on EMI suppression. The Walsin High frequency chip inductors are manufactured by Multilayer fabrication technology providing excellent electrical performance. The inductors are supplied in reel taping, making them suitable for automatic Pick & Place equipment. Cooperating with environmental protection, We provided Pb-Free products for customer request.

SHAPE and DIMENSION



MARKING

Polarity mark



Unit: mm (inches)

	L	W	T	B
1005	1.0 [0.040] ±0.1 [0.004]	0.5 [0.020] ±0.1 [0.004]	0.5 [0.020] ±0.1 [0.004]	0.25 [0.010] ±0.10 [0.004]

Ordering Information

WL	10 05 05	G	4N7	S	G	T	03
Product Code	Dimension code	Material	Inductance	Tolerance	Specification	Packing Code	Rated Current
WL: Inductor	100505 = L: 1.0mm W: 0.5mm T: 0.5mm	A, B, C, D, E, F, G	For Ls < 10nH, N = Decimal Point e.g. 4N7 = 4.7nH	B: ± 0.1nH S: ± 0.3nH J: ± 5% K: ±10% C: Customized	N= Normal A= ± 0.2nH G= Green	T= Reeled B = Bulk	03= 250mA or 300mA 02= 150mA or 200mA

Electrical Characteristics – 0402 MLCI

Walsin Part Number	L(nH)	Tolerance	Q Min	Typical Q @ Frequency			SRF Typical (MHz)	RDC Maximum (Ω)	IDC (mA)
			(MHz)	100	800	1800			
WL100505G1N0SGT03	1.0	± 0.3nH	8	9	27	44	13000	0.12	300
WL100505G1N2SGT03	1.2	± 0.3nH	8	9	25	45	12000	0.12	300
WL100505G1N5SGT03	1.5	± 0.3nH	8	9	23	43	10000	0.13	300
WL100505G1N8SGT03	1.8	± 0.3nH	8	9	24	43	9000	0.14	300
WL100505G2N2SGT03	2.2	± 0.3nH	8	9	26	45	9000	0.16	300
WL100505G2N7SGT03	2.7	± 0.3nH	8	9	26	42	8000	0.17	300
WL100505G3N3SGT03	3.3	± 0.3nH	8	9	26	42	6500	0.19	300
WL100505G3N9□GT03	3.9	± 0.3nH ±10%	8	9	26	40	6000	0.22	300
WL100505G4N7□GT03	4.7	± 0.3nH ±10%	8	9	27	46	5000	0.23	300
WL100505G5N6□GT03	5.6	± 0.3nH ±10%	8	10	28	40	4700	0.27	300
WL100505G6N8□GT03	6.8	±5% ±10%	8	10	28	36	4500	0.32	250
WL100505G8N2□GT03	8.2	±5% ±10%	8	10	28	36	4000	0.37	250
WL100505G10N□GT03	10	±5% ±10%	8	10	27	33	3500	0.42	250
WL100505G12N□GT03	12	±5% ±10%	8	11	31	41	3000	0.48	250
WL100505G15N□GT03	15	±5% ±10%	8	10	27	33	2900	0.53	250
WL100505G18N□GT02	18	±5% ±10%	8	11	29	31	2200	0.65	200
WL100505G22N□GT02	22	±5% ±10%	8	10	26	15	2100	0.80	200
WL100505G27N□GT02	27	±5% ±10%	8	10	23	15	2000	0.90	200
WL100505G33N□GT02	33	±5% ±10%	8	10	*22	**24	1900	1.00	200
WL100505G39N□GT02	39	±5% ±10%	8	10	*19	**20	1800	1.20	200
WL100505G47N□GT02	47	±5% ±10%	8	12	*22	**20	1500	1.30	200
WL100505G56N□GT02	56	±5% ±10%	8	12	*22	**18	1400	1.60	200
WL100505G68N□GT02	68	±5% ±10%	8	11	*18	**10	1200	1.90	180
WL100505G82N□GT02	82	±5% ±10%	8	12	*20	**7	1100	2.10	150
WL100505GR10□GT01	100	±5% ±10%	8	11	*18	-	930	2.30	100

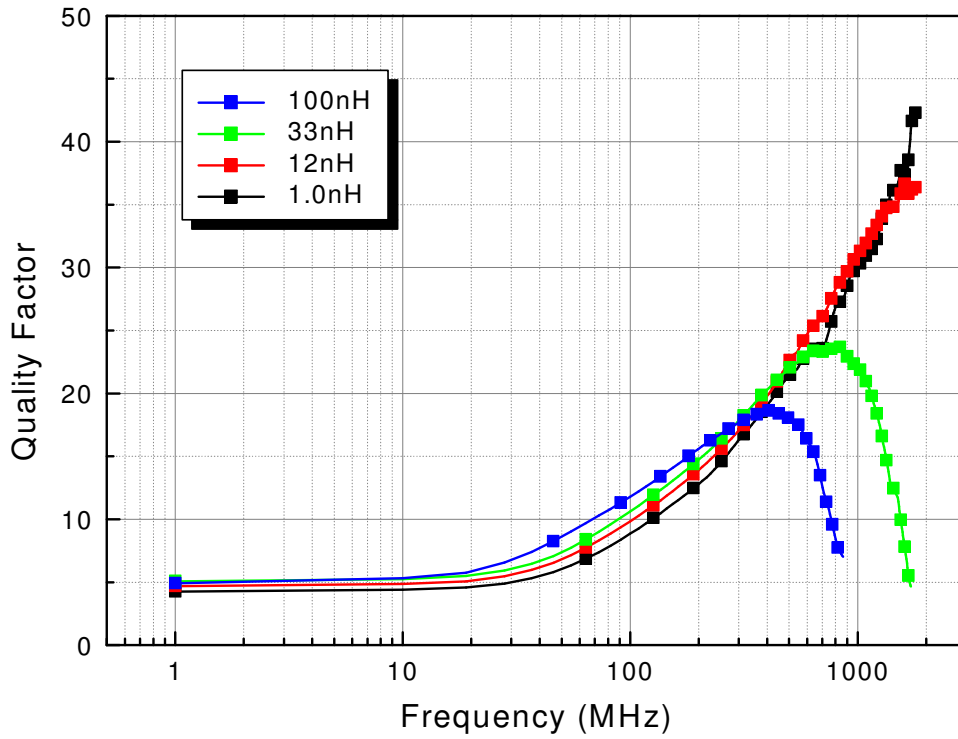
*: 500MHz, **: 1000MHz

【Test Instruments】

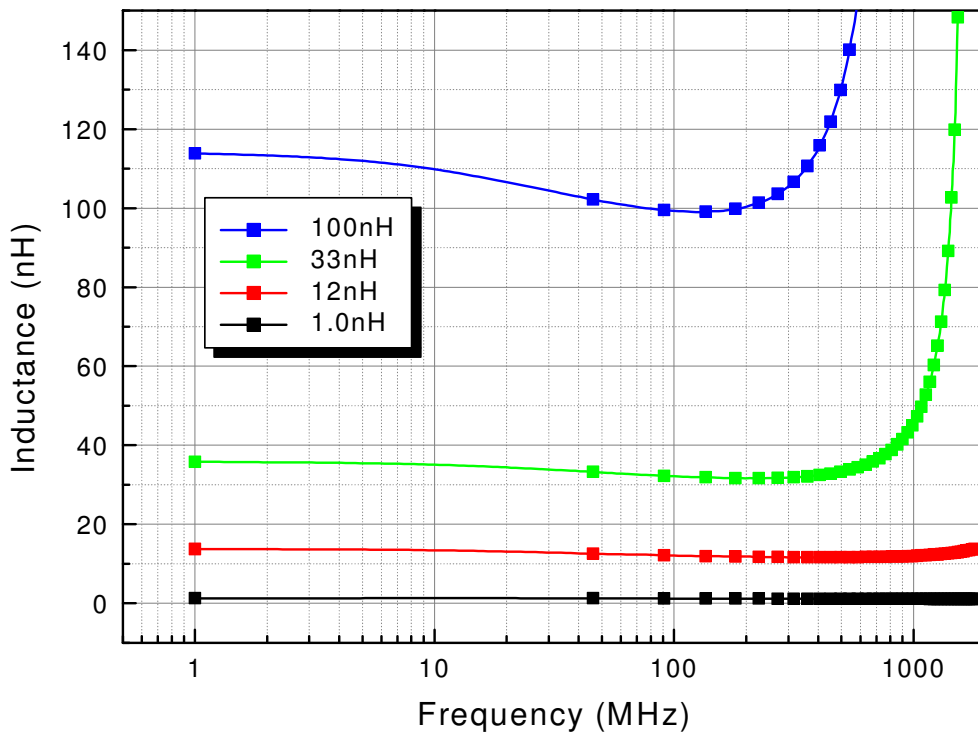
L.Q.: HP4291B (Text Fixture: HP16192A),
 SRF: Anritsu 37247B,
 RDC: HP4263B,
 IDC: HP6612C

ELECTRICAL CHARACTERISTICS

Quality Factor vs. Frequency



Inductance vs. Frequency



STANARD TEST and RELIABILITY TEST

- Temperature : 15~35°C
- Humidity : 25%RH~85%RH
- Atmospheric pressure : 96kPa ~ 106kPa

1. Electrical performance test

Item	Method & Criteria
Inductance/Q(Quality factor)	Unit : nH/Constant Test frequency : 100MHz Equipment : Impedance material analyzer
SRF(Self Resonant Frequency)	Unit : MHz Test frequency : Frequency sweep(40MHz~20GHz) Equipment : Network analyzer
DC(Direct Current)resistance	Unit : mΩ (ohm) Test frequency : LCR meter
Rated current	Unit : mA Test frequency : Current Sweep Equipment : Power supply (DC current source)

2. Reliability Test

TCL	Unit : Temperature coefficient of L(PPM/°C) Test Temperature : -40°C~125°C(referring to L at 20°C) Equipment : TC Chamber(with Impedance analyzer, Ohmmeter, power supply PC, Printer) ◇ Basically, DC bias make no difference on L and Q, in glass ceramic inductors Requirements : L shall be within ±10% of the initial value.																				
Thermal Resistance (Temperature cycle)	Unit : Appearance, Electrical Characteristics Test condition : <table border="1" style="margin-left: 40px;"> <thead> <tr> <th>Step</th> <th>1</th> <th>2</th> <th>3</th> <th>4</th> </tr> </thead> <tbody> <tr> <td>Temp.</td> <td>-40±2°C</td> <td>room temp.</td> <td>+125±2°C</td> <td>room temp.</td> </tr> <tr> <td>Time</td> <td>30min</td> <td>2-3min</td> <td>30min</td> <td>2-3min</td> </tr> <tr> <td>Cycle</td> <td colspan="4" style="text-align: center;">100 cycles/test</td> </tr> </tbody> </table> Equipment : TC chamber or Temp. controlled chamber (programmable) Procedure : 1) Measure the initial values(L,Q,Rdc) 2) Carry out the test as described above 3) make measurements after ambient air exposure for 24±2 hours. Requirements : No apparent damage L shall be within ±10% of the initial value. Q shall be within ±20% of the initial value.	Step	1	2	3	4	Temp.	-40±2°C	room temp.	+125±2°C	room temp.	Time	30min	2-3min	30min	2-3min	Cycle	100 cycles/test			
Step	1	2	3	4																	
Temp.	-40±2°C	room temp.	+125±2°C	room temp.																	
Time	30min	2-3min	30min	2-3min																	
Cycle	100 cycles/test																				

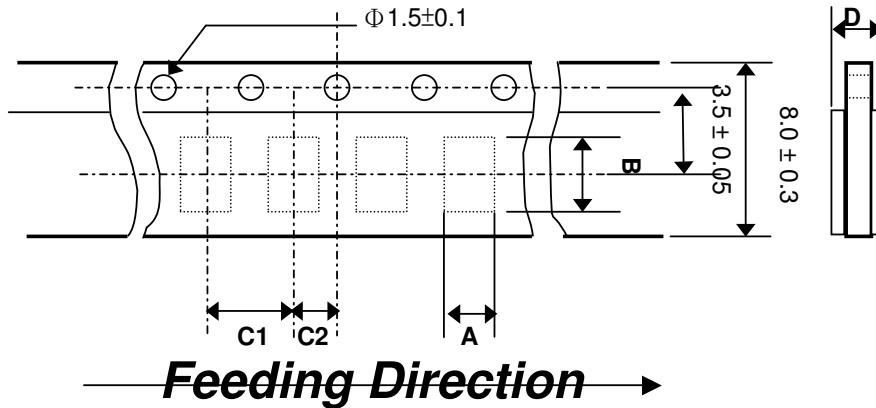
<p>Humidity Resistance</p>	<p>Unit : Mechanical, Electrical Characteristics</p> <p>Test condition : Humidity ; 90-95%RH</p> <ul style="list-style-type: none"> • Temp :60°C • Time : 500±12 hours neglected. <p>Equipment : Constant temperature & humidity chamber</p> <p>Procedure : 1) Measure the initial values(L,Q,Rdc)</p> <p style="padding-left: 40px;">2) Carry out the test as described above</p> <p style="padding-left: 40px;">3) make measurements after ambient air exposure for 24±2 hours.</p> <p>Requirements : No apparent damage</p> <p style="padding-left: 40px;">L shall be within ±10% of the initial value.</p> <p style="padding-left: 40px;">Q shall be within ±20% of the initial value.</p>
<p>High Temperature Resistance</p>	<p>Unit : Mechanical, Electrical Characteristics</p> <p>Test condition : Temp.; 125±2°C</p> <p style="padding-left: 40px;">Time ;1000±12 hours under unloading.</p> <p>Equipment : Constant temperature & humidity chamber</p> <p>Procedure : 1) Measure the initial values(L, Q, Rdc)</p> <p style="padding-left: 40px;">2) Carry out the test as described above</p> <p style="padding-left: 40px;">3) make measurements after ambient air exposure for 24±2 hours.</p> <p>Requirements : No apparent damage</p> <p style="padding-left: 40px;">L shall be within ±10% of the initial value.</p> <p style="padding-left: 40px;">Q shall be within ±20% of the initial value.</p>
<p>Low Temperature Resistance</p>	<p>Unit : Mechanical, Electrical Characteristics</p> <p>Test condition : Temp.; -40±2°C</p> <p style="padding-left: 40px;">Time ;1000±12 hours under unloading.</p> <p>Equipment : Constant temperature & humidity chamber</p> <p>Procedure : 1) Measure the initial values(L, Q, Rdc)</p> <p style="padding-left: 40px;">2) Carry out the test as described above</p> <p style="padding-left: 40px;">3) make measurements after ambient air exposure for 24±2 hours.</p> <p>Requirements : No apparent damage</p> <p style="padding-left: 40px;">L shall be within ±10% of the initial value.</p> <p style="padding-left: 40px;">Q shall be within ±20% of the initial value.</p>

<p>8585 Test</p>	<p>Unit : Mechanical, Electrical Characteristics Test condition : Temp. ; 85±2°C . Humidity ; 85±5% .Time ; 100±12 hours Equipment : Constant temperature & humidity chamber Procedure :1) Measure the initial values(L, Q, Rdc) 2) Carry out the test as described above 3) Make measurements after the ambient air exposure for 24±2 hours Requirements : No mechanical damage L shall be within ±10% of the initial value. Q shall be within ±20% of the initial value.</p>
<p>Loading under Damp Heat</p>	<p>Unit : Mechanical, Electrical Characteristics Test condition : Temp :60±2°C . Humidity : 90~95%RH .:Time : 500±12 hours :Apply current: Rated current Equipment : Constant temperature & humidity chamber Procedure :1) Measure the initial values(L, Q, Rdc) 2) Carry out the test as described above 3) Make measurements after the ambient air exposure for 1 to 2 hours of recovery Requirements : No mechanical damage L shall be within ±10% of the initial value. Q shall be within ±20% of the initial value.</p>
<p>Loading at High Temperature</p>	<p>Unit : Mechanical, Electrical Characteristics Test condition : Temp :125±2°C :Time : 500±12 hours :Apply current: Rated current Equipment : Constant temperature & humidity chamber Procedure :1) Measure the initial values(L, Q, Rdc) 2) Carry out the test as described above 3) Make measurements after the ambient air exposure for 1 to 2 hours of recovery Requirements : No mechanical damage L shall be within ±10% of the initial value. Q shall be within ±20% of the initial value.</p>

PACKAGE SPECIFICATION

■ **Carrier Tape Dimensions**

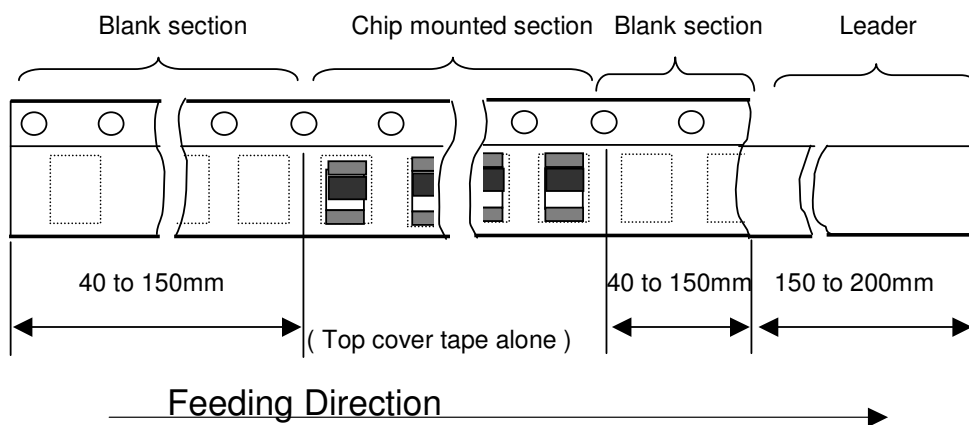
- Carrier Tape material : Paper
- Dimension in millimeters



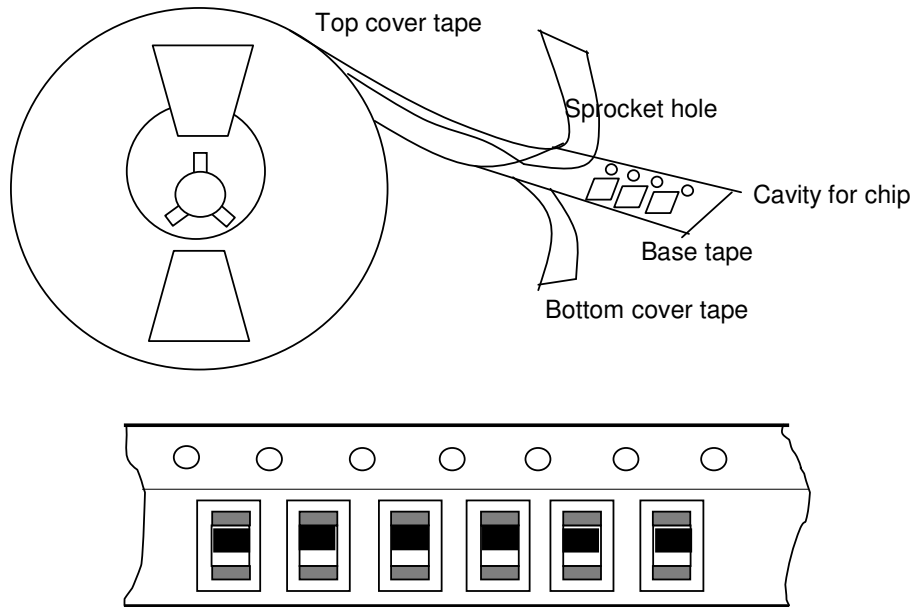
Series	Chip cavity	Chip cavity	Insertion pitch	Insertion pitch	Tape thickness
	A	B	C1	C2	D
1005	0.685 ±0.015	1.215 ±0.015	2.0 ±0.1	2.0 ±0.05	0.8max

Dimensions of Taping

-Leader and blank section

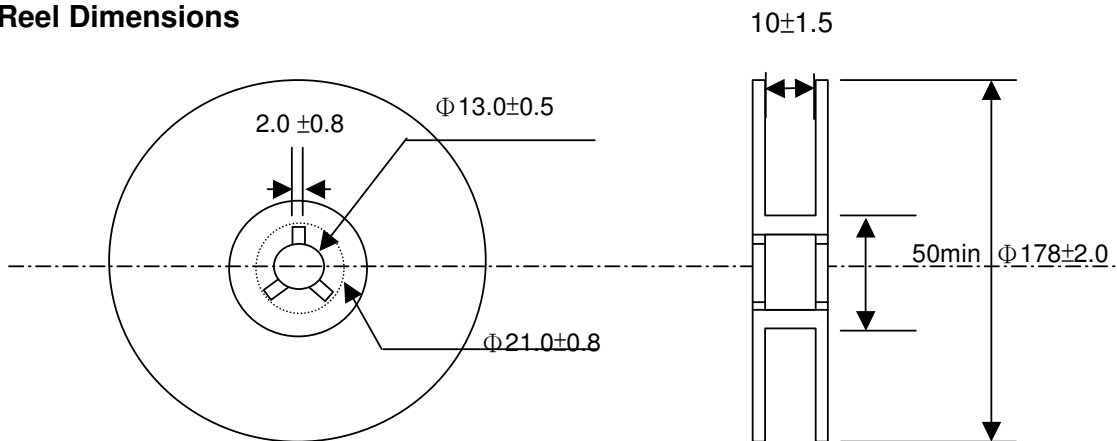


Appearance of taping



Packed chip

Reel Dimensions



- Reel material : Polystyrene
- Ordering code No., Quantity, Batch No. and Walsin
- Parts per reel : 10,000 pcs / reel

CAUTION OF HANDLING

Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects, which might directly cause damage to the third party's life, body or property.

- (1) Aircraft equipment
- (2) Aerospace equipment
- (3) Undersea equipment
- (4) Medical equipment
- (5) Disaster prevention / crime prevention equipment
- (6) Traffic signal equipment
- (7) Transportation equipment (vehicles, trains, ships, etc.)
- (8) Applications of similar complexity and /or reliability requirements to the applications listed in the above.

Storage condition

- (1) Products should be used in 6 months from the day of WALSIN outgoing inspection, which can be confirmed.
- (2) Storage environment condition.
 - Products should be storage in the warehouse on the following conditions.
 - Temperature : -10 to +40°C
 - Humidity : 30 to 70% relative humidity
 - Don't keep products in corrosive gases such as sulfur. Chlorine gas or acid or it may cause oxidization of electrode, resulting in poor solderability.
 - Products should be storage on the palette for the prevention of the influence from humidity, dust and son on.
 - Products should be storage in the warehouse without heat shock, vibration, direct sunlight and so on.
 - Products should be storage under the airtight packaged condition.